Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/617,113	CHOWN, DAVID	
Examiner	Art Unit	
Leslie Pascal	2613	

SEARCHED					
Class	Subclass	Date	Examiner		
398	135-139	11/7/2006	LP		
	. —		-		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>	<u> </u>		

	H NOTES ARCH STRATEGY)
	DATE	EXMR
see search notes	11/6/2007	_P
	•	